

## Message Text

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PAGE 01 OECD P 19343 290115Z

64

ACTION EB-07

INFO OCT-01 CIAE-00 COME-00 DODE-00 NSAE-00 TRSE-00 EUR-12

ERDA-05 ISO-00 EA-06 MC-02 /033 W

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P 251557Z JUL 75

FM USMISSION OECD PARIS

TO SECSTATE WASHDC PRIORITY 8074

C O N F I D E N T I A L OECD PARIS 19343

EXCON

C O R R E C T E D C O P Y (REF SHUD READ 1483 VICE 1482)

E.O. 11652: XGDS1

TAGS: ESTC, COCOM, CH, JA

SUBJECT: JAPANESE IC TESTER TO CHINA - IL 1355

REF: COCOM DOC (75) 1483

1. URGENT REQUEST: IC TESTER MODEL SM-0005C.  
VALUE \$6,000. GO/NO-GO TEST METHOD 16 TEST PINS AT  
MAX. INPUT 12 AT MAX, OUTPUT 10 AT MAX. VCC, GND,  
VIH, VIL, CLEAR, PRESET, CLOCK, RL (1K), SHORT.  
INPUT SIGNAL 4096 BITS AT MAX. END USER FUDAN  
UNIVERSITY, SHANGHAI FOR RESEARCH PURPOSES.
2. EQUIPMENT NOW IN CHINA WITH JAPANESE EXHIBITION AND  
SCHEDULED FOR REMOVAL UNLESS SALE APPROVAL OBTAINED.
3. VIEWS REQUESTED 8/LW, PLEASE INSTRUCT.  
TURNER

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NNN

## Message Attributes

**Automatic Decaptioning:** X  
**Capture Date:** 01 JAN 1994  
**Channel Indicators:** n/a  
**Current Classification:** UNCLASSIFIED  
**Concepts:** ELECTRONIC EQUIPMENT, STRATEGIC TRADE CONTROLS, EXCEPTIONS LIST  
**Control Number:** n/a  
**Copy:** SINGLE  
**Draft Date:** 25 JUL 1975  
**Decaption Date:** 01 JAN 1960  
**Decaption Note:**  
**Disposition Action:** RELEASED  
**Disposition Approved on Date:**  
**Disposition Authority:** GarlanWA  
**Disposition Case Number:** n/a  
**Disposition Comment:** 25 YEAR REVIEW  
**Disposition Date:** 28 MAY 2004  
**Disposition Event:**  
**Disposition History:** n/a  
**Disposition Reason:**  
**Disposition Remarks:**  
**Document Number:** 1975OECDP19343  
**Document Source:** CORE  
**Document Unique ID:** 00  
**Drafter:** n/a  
**Enclosure:** n/a  
**Executive Order:** X1  
**Errors:** N/A  
**Film Number:** D750260-0470  
**From:** OECD PARIS  
**Handling Restrictions:** n/a  
**Image Path:**  
**ISecure:** 1  
**Legacy Key:** link1975/newtext/t19750721/aaaaatal.tel  
**Line Count:** 47  
**Locator:** TEXT ON-LINE, ON MICROFILM  
**Office:** ACTION EB  
**Original Classification:** CONFIDENTIAL  
**Original Handling Restrictions:** n/a  
**Original Previous Classification:** n/a  
**Original Previous Handling Restrictions:** n/a  
**Page Count:** 1  
**Previous Channel Indicators:** n/a  
**Previous Classification:** CONFIDENTIAL  
**Previous Handling Restrictions:** n/a  
**Reference:** n/a  
**Review Action:** RELEASED, APPROVED  
**Review Authority:** GarlanWA  
**Review Comment:** n/a  
**Review Content Flags:**  
**Review Date:** 16 MAY 2003  
**Review Event:**  
**Review Exemptions:** n/a  
**Review History:** RELEASED <16 MAY 2003 by ShawDG>; APPROVED <02 JUN 2003 by GarlanWA>  
**Review Markings:**

Margaret P. Grafeld  
Declassified/Released  
US Department of State  
EO Systematic Review  
06 JUL 2006

**Review Media Identifier:**  
**Review Referrals:** n/a  
**Review Release Date:** n/a  
**Review Release Event:** n/a  
**Review Transfer Date:**  
**Review Withdrawn Fields:** n/a  
**Secure:** OPEN  
**Status:** NATIVE  
**Subject:** JAPANESE IC TESTER TO CHINA - IL 1355  
**TAGS:** ESTC, CH, JA, COCOM  
**To:** STATE  
**Type:** TE  
**Markings:** Margaret P. Grafeld Declassified/Released US Department of State EO Systematic Review 06 JUL 2006